

Notice of References Cited	Application/Control No. 09/885,001	Applicant(s)/Patent Under Reexamination SHIIZAKI ET AL.	
	Examiner XIAO M. WU	Art Unit 2674	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,144,349	11-2000	Awata et al.	345/67
	B	US-6,320,326	11-2001	Shino et al.	315/169.4
	C	US-6,342,873	01-2002	Ueoka et al.	345/60
	D	US-6,344,841	02-2002	Moon, Seong Hak	345/60
	E	US-6,380,912	04-2002	Kang et al.	345/60
	F	US-6,489,722	12-2002	Yoshida et al.	313/582
	G	US-6,504,519	01-2003	Ryu et al.	345/60
	H	US-2001/0024092	09-2001	Kim et al.	315/169.4
	I	US-2002/0039086	04-2002	Hirakawa et al.	345/60
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.